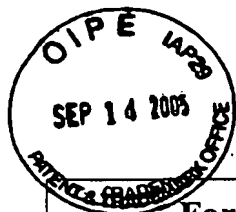


<b>Form PTO-1449 Modified</b>  List of Patent and Publications Cited by Applicant (Use several sheets if necessary)  U.S. Department of Commerce Patent and Trademark Office				Docket No. <b>TIC-0063</b>		Application No. <b>10830186</b>	
				Applicants <b>Tetsuhiko Fukanuma, et al.</b>			
				Filing Date <b>Herewith.</b>		Group <b>3746</b>	
				Confirmation No. <b>Not yet assigned.</b>			
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U.S. Department of Commerce  
Patent and Trademark Office

Docket No.  
**TIC-0063/P1P2004058US**

Application No.  
**10/830,186**

Applicant  
**Tetsuhiko Fukanuma, Masahiro Kawaguchi,  
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Hiroyuki Nakaima**

Filing Date  
**April 22, 2004**

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**DATE CONSIDERED** 06/18/2007